Self Test Ground Fault Circuit Interrupter (GFCI)

NCS37015

The NCS37015 is a UL943 compliant signal processor for GFCI applications with self test. The device integrates a flexible power supply (including a 12 V shunt and two 3.3 V internal series regulators), differential fault, and grounded—neutral detection circuits. Self test is monitored at start up and then every 17 minutes.

Features

- Meets UL943 Self-test GFCI Requirements
- 4.0 12 Volt Operation (120–480 V AC mains with the appropriate series impedance)
- -40°C to 95°C
- Typical 575 μA Quiescent Current @ 11 V
- 16 Pin QFN
- Inverted and Latched SCR Output to Facilitate a Solenoid Operation
- Self Syncing Internal Oscillator adjusts to AC Mains Frequency to Guarantee Full Resolution on 60 Hz Distribution Systems
- Optimized Solenoid Deployment (coil is not energized near the AC mains zero crossings)
- Power Supply Monitor that Verifies Full Diode Bridge Operation
- Tiered Trip Times that Increase Immunity to Noise
- Under-voltage Detection that Allows for Increased Operation at Lower AC Input Voltages

Typical Applications

- Portable GFCI Plugs
- GFCI Receptacles



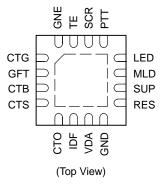
ON Semiconductor®

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QFN16 CASE 485FQ

PIN ASSIGNMENT



MARKING DIAGRAM



37015 = Specific Device Code A = Assembly Location

L = Wafer Lot Y = Year W = Work Week • Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering and shipping information on page 8 of this data sheet.

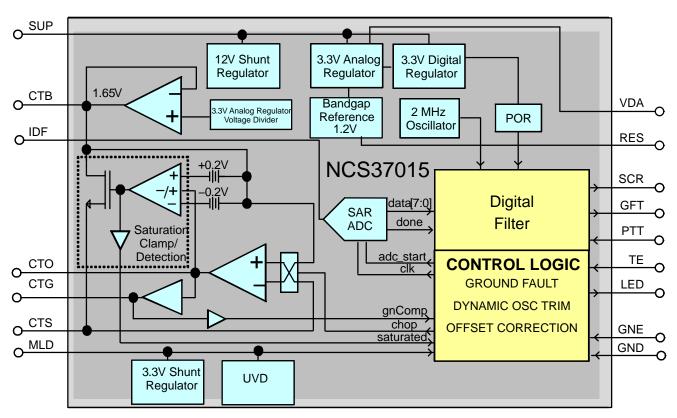


Figure 1. Simplified Block Diagram

Table 1. QFN PIN DESCRIPTION

| Pin# | Name | Pad Description | |
|------|------|--|--|
| 1 | CTG | Ground Neutral current transformer stimulus | |
| 2 | GFT | Differential self test output signal | |
| 3 | СТВ | Differential current transformer bias voltage | |
| 4 | CTS | Differential current input | |
| 5 | СТО | Differential current to voltage output | |
| 6 | IDF | Differential low pass filter/ADC input | |
| 7 | VDA | Analog 3.3 V regulator output/ ADC reference voltage | |
| 8 | GND | Electronics ground | |
| 9 | RES | Reference current bias input | |
| 10 | SUP | Power supply input | |
| 11 | MLD | Mains level/under voltage detector | |
| 12 | LED | End of life LED drive | |
| 13 | PTT | Push to test input | |
| 14 | SCR | SCR gate drive signal | |
| 15 | TE | Test enable | |
| 16 | GNE | Ground-neutral enable input | |

Table 2. ABSOLUTE MAXIMUM RATINGS

| Rating | Symbol | Value | Unit |
|---|---------------------|---|------|
| Supply Voltage Range | Vs | 13.5 | V |
| Supply Current | Is | 10 | mA |
| Input Voltage Range (Note 3) | V _{in} | -0.3 to 3.6 | V |
| Output Voltage Range | V _{out} | -0.3 to 3.6 V or (V _{in} + 0.3), whichever is lower | V |
| Maximum Junction Temperature | T _{J(max)} | 140 | °C |
| Storage Temperature Range | TSTG | -65 to 150 | °C |
| ESD Capability, Human Body Model (Note 4) | ESD _{HBM} | 2 | kV |
| ESD Capability, Charge Device Model (Note 4) | ESD _{CDM} | 500 | V |
| Lead Temperature Soldering Reflow (SMD Styles Only), Pb–Free Versions (Note 5) | T _{SLD} | 260 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Functional operation above the Recommended Operating Conditions is not implied. Extended
- Exposure to stresses above the Recommended Operating Conditions may affect device reliability.
 Refer to ELECTRICAL CHARACTERISTICS and APPLICATION INFORMATION for Safe Operating Area.
- 4. This device series incorporates ESD protection and is tested by the following methods:

 - ESD Human Body Model tested per JS-001-2012 ESD Charge Device Model tested per JESD22-C101-F
 - Latchup Current Maximum Rating: ≤100 mA per JEDEC standard: JESD78D
- 5. For information, please refer to our Soldering and Mounting Techniques Reference Manual, SOLDERRM/D

Table 3. THERMAL CHARACTERISTICS

| Rating | Symbol | Value | Unit |
|--|-----------------|-------|------|
| Thermal Characteristics, QFN16, 3x3.3 mm (Note 6) Thermal Resistance, Junction–to–Air (Note 7) | $R_{\theta JA}$ | 64 | °C/W |

- 6. Refer to ELECTRICAL CHARACTERISTICS and APPLICATION INFORMATION for Safe Operating Area.
- 7. Values based on copper area of 645 mm² (or 1 in²) of 1 oz copper thickness and FR4 PCB substrate.

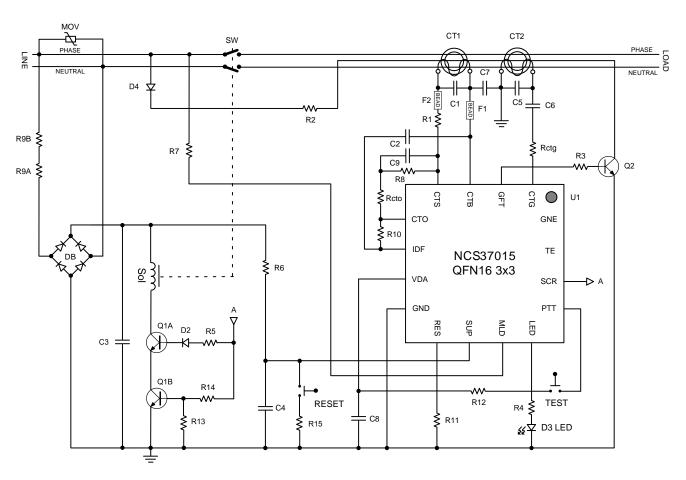
Table 4. OPERATING RANGES (Unless otherwise noted, I_{SUP} = 3 mA, MLD input = 60 Hz, Refer to Figure 2)

| Parameter | Conditions | Min | Тур | Max | Units |
|---------------------------------------|--|------|------|-----|---------|
| Operating Temperature | Ambient - | | | 95 | С |
| Shunt Regulator Voltage | SUP to GND, I _{SUP} = 1 mA | | 12 | 13 | V |
| Shunt Regulator Current | I _{SUP} | | | 10 | mA |
| Quiescent Current | I _{SUP} , SUP = 10.5 V | | 575 | 750 | μΑ |
| RMS Trip Threshold Voltage | IDF to CTB, R8 = 32 k Ω , R _{CTO} = 500 Ω | 191 | 203 | 215 | mV |
| SCR Trigger Current | I _{SCR} , SCR = 1 V, I _{SHUNT} < 6 mA | 4 | | | mA |
| SCR Trigger Output Voltage | SCR to GND, SUP < 4 V | 3 | | 3.6 | V |
| LED Output Voltage | LED to GND, SUP < 4 V | 3 | | 3.6 | V |
| CTB Bias Voltage | CTB to GND, VDA = 3.3 V | | 1.65 | | V |
| CTS-CTB Absolute Offset Voltage | CTS-CTB | -250 | | 250 | μV |
| Fault Response Time | 6 mA ≤ I _{DIFF} < 10 mA | | | 125 | ms |
| Fault Response Time | 10 mA ≤ I _{DIFF} < 15 mA | | | 95 | ms |
| Fault Response Time | 15 mA ≤ I _{DIFF} < 17.5 mA | | | 75 | ms |
| Fault Response Time | 17.5 mA ≤ I _{DIFF} < 20 mA | | | 60 | ms |
| Fault Response Time | 20 mA ≤ I _{DIFF} < 22.5 mA | | | 50 | ms |
| Fault Response Time | 22.5 mA ≤ I _{DIFF} < 26.5 mA | | | 40 | ms |
| Fault Response Time | 26.5 mA ≤ I _{DIFF} < 29 mA | | | 35 | ms |
| Fault Response Time | 29 mA ≤ I _{DIFF} < 33 mA | | | 25 | ms |
| Fault Response Time | I _{DIFF} ≥ 33 mA | | | 20 | ms |
| CTG Comparator Threshold | CTG to GND, VDA = 3.3 V | | 1.95 | | V |
| CTG Timer | CTG > Threshold | | 45 | | μs |
| CTG GN Trip Frequency | CTG to GND | | | 7 | kHz |
| GN Response Time | Continuous GN Fault | | | 350 | ms |
| Internal Oscillator Frequency | F _{AC} = 60 Hz ±0.1 | 1.8 | 2 | 2.2 | MHz |
| Under Voltage Detect | V_{AC} to GND, R7 = 1 M Ω , ±1% | 80 | 87 | 95 | Vrms |
| MLD Max Clamp Current | I _{MLD} Max Sink Current | | | 400 | μΑ |
| MLD Pull Down Current | MLD = 1 V | | 500 | | nA |
| First ST Timer | VDA > 3 V | 1.7 | 2 | 2.3 | seconds |
| Periodic ST Timer, Pass | Steady State, ST Pass | 15 | 17 | 20 | minutes |
| LED Blink Frequency | First ST Failure | 1.8 | 2 | 2.2 | Hz |
| ST Cycle GF Pass Window | I _{DIFF} Ground Fault | 6 | | 14 | mA |
| MLD Pin Check Wait Time to Enable LED | No MLD signal | | 500 | | ms |
| MLD Pin Continuity Pass | Input Frequency | 25 | | | Hz |
| LED Blink Frequency | No MLD signal | 1.5 | 2 | 2.5 | Hz |
| MLD Pin Check Wait Time to Enable SCR | No MLD signal | | 6 | | minutes |

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

8. Refer to ELECTRICAL CHARACTERISTICS and APPLICATION INFORMATION for Safe Operating Area.

APPLICATIONS INFORMATION



Note: A practical design for a portable GFCI application can be changed based on the requirements of a latching mechanism of a switch.

Figure 2. Portable GFCI Application Diagram (example)

Table 5. RECOMMENDED EXTERNAL COMPONENTS

| Component Type | Instance | Value | Note |
|---------------------|--------------|-------------------|--|
| NPN | Q1A, Q1B, Q2 | - | MMBT6517LT1-D |
| Diode Bridge | DB | - | |
| Diode | D2, D4 | - | 1N4007 |
| LED | D3 | - | LED for self test failure |
| Capacitor | C1 | 33 nF | Differential current filter capacitor |
| Capacitor | C2 | 56 nF | Anti-aliasing filter (1 kHz corner frequency) |
| Capacitor | C3 | 10 μF | Solenoid firming capacitor |
| Capacitor | C4 | 1 μF | SUP pin holding capacitor |
| Capacitor | C5 | 22-220 pF | Ground Neutral CT resonance capacitor |
| Capacitor | C6 | 4.7–47 nF | Ground Neutral CT AC coupler |
| Capacitor | C7 | 1 nF | CTB bias filter |
| Capacitor | C8 | 1 μF | Analog 3.3 V regulator filter |
| Capacitor | C9 | 1 nF | High frequency filter |
| Capacitor | C10 | 0.1–1 nF | High frequency filter for zero cross |
| Resistor | R1 | 243 Ω | Precision resistor (1%) differential low pass filter |
| Resistor | R2 | - | Sets a resistance to create 8 mA fault current |
| Resistor | R3 | 10 kΩ | Sets the current in the base of Q2 |
| Resistor | R4 | 6.8 kΩ | Limits current to the LED D3 |
| Resistor | R5 | 20–47 kΩ | Sets base current in Q1A |
| Resistor | R6 | 72 kΩ | Power supply current limit |
| Resistor | R7 | 1 ΜΩ | MLD current limit/under voltage attenuator |
| Resistor | R8 | 32 kΩ | Precision resistor (1%) for differential trip level |
| Resistor | R9A, R9B | 3.3–15 k Ω | Diode bridge short current limit |
| Resistor | R10 | 10–20 kΩ | Differential filter resistor |
| Resistor | R11 | 120 kΩ | Precision resistor (1%), Current reference bias resistor |
| Resistor | R12 | 10 kΩ | Test button pull-up resistor |
| Resistor | R13 | 47 kΩ | Q1B base pull-down resistor |
| Resistor | R14 | 20–47 kΩ | Sets base current in Q1B |
| Resistor | R15 | 22 kΩ | Reset button pull-down resistor |
| Resistor | Rcto | 0.47–1.5 kΩ | Precision resistor (1%), Sets the differential trip level at 5 mA _{RMS} |
| Resistor | Rctg | 0 – 200 Ω | Sets the GN sensitivity |
| Current Transformer | CT1 | 800 | Differential current transformer |
| Current Transformer | CT2 | 250 | GN current transformer |

Functional Description (refer to application circuit)

The NCS37015 provides for a single IC controller solution for ground fault, grounded neutral and self–test protection per UL standard UL943 for GFCI applications.

The key internal blocks include: 12 V shunt regulator, precision bandgap reference, two 3.3 V linear regulators (one for the digital and one for the analog circuit) sense amplifier with V_{OS} cancellation, 1.65 V reference for the CT, 2 MHz oscillator dynamically trimmed to the AC line frequency, 8 bit SAR ADC, comparators, digital filters and digital control logic.

To work more easily with portable GFCI applications the SCR pin will assert high on power—up. If a fault is detected or self—test fails the SCR pin will drive low and remain in this state until the part goes through a power on reset.

The internal shunt regulator clamps the SUP pin voltage at 12 volts. This provides the bias voltage for the analog (vda) and digital (vdd) internal circuitry via two 3.3 V linear regulators.

At POR detection (vda>2.475) the logic is reset and the bias circuitry is enabled, the LED pin will blink once for 250 ms. The MLD pin is continually checked for an input signal greater than 25 Hz. If the MLD signal is greater than 25 Hz, this test passes. If it fails, the LED blinking logic will be enabled. A six minute timer will start and if no MLD signal is detected, the SCR will be enabled. If a MLD signal occurs before the six minute timer and is longer than one minute, the timer will be reset.

The first self test (ST) cycle will occur at two seconds and thereafter every 17 minutes. During the ST cycle the GFT pin will be enabled and the CT current (set at 8 mA, R2) will be verified for two half cycles. If a ST cycle fails due to a low GF detection or a GF signal greater than 30 mA, the LED blinking logic will enable and the SCR pin will assert low.

The CT is biased at 1.65 volts. The sense amplifier monitors the ground fault current. This current is converted to a voltage level at the CTO pin which is the input to the ADC (IDF pin). The resistor R8 sets the GF threshold per the following equation:

$$I_{diff} = \frac{0.203 \times CT_{1} \times \left(R_{CT1} + R_{1} + 2\pi f_{AC}L_{CT1}\right)}{R_{8} \times \left(R_{CT1} + 2\pi f_{AC}L_{CT1}\right)}$$
(eq. 1)

 CT_1 = Turns ratio of differential CT

 $R_{CT1} = DC$ winding resistance of differential CT

 $f_{AC} = AC$ mains frequency

 L_{CT1} = Inductance of differential CT

The ground fault detection circuit has different levels of time delay before the SCR is enabled:

| ine delay ecrore the best is ender | cu. |
|------------------------------------|--------------|
| 6 mA to 10 mA | ≤ 125 ms |
| 10 mA to 15 mA | ≤ 95 ms |
| 15 mA to 17.5 mA | ≤ 75 ms |
| 17.5 mA to 20 mA | ≤ 60 ms |
| 20 mA to 22.5 mA | \leq 50 ms |
| 22.5 mA to 26.5 mA | \leq 40 ms |

| 26.5 mA to 29 mA | ≤ 35 ms |
|------------------|---------|
| 29 mA to 33 mA | ≤ 25 ms |
| >33 mA | ≤ 20 ms |

If a very high GF occurs and a greater than 200 mV signal occurs across the CT for greater than 1.4 ms, the SCR pin will be driven low immediately.

Note that the above equation is for an ideal CT. In practice, the GF threshold can be $\pm 30\%$ different and should be empirically set.

When the PTT pin is enabled for greater than 64ms and if the GNE PIN is high (16ms when GNE PIN is low), a ST cycle will be enabled. If the ST cycle passes, the SCR pin will drive to 0V and the LED blinks once. If the ST cycle fails, the LED will enable to blink and the SCR pin will drive to 0 V.

The PTT pin has a 50 k Ω pull down resistor. This pin is a CMOS input with hysteresis. To enable the PTT function, the input voltage should go above 2.4 volts.

The MLD pin monitors the phase and zero cross for the AC supply. The MLD circuit clamps the pin voltage to gnd and vda. When the pin is clamped at vda, the current is compared to a threshold so if the VAC voltage is below 87 V_{RMS}, the ST GF threshold will be reduced by 50%. This function provides for an AC under voltage detection which allows for the ST cycle to pass with a lower GF threshold. The AC UVD threshold can be user programmable by changing R7.

Grounded Neutral detection is accomplished by the addition of a GN coil to generate a "dormant oscillator" circuit. When a GN condition occurs, both the sense coil and GN coils are mutually coupled and the GN amplifier will oscillate. This oscillation can be observed at the CTG pin. When the oscillation at the CTG pin is above 1.95 volts for greater than 45 µs, and if this condition (oscillation) lasts for longer than 64 ms, the internal NCS37015 logic will disable the GN amplifier to stop the CTG oscillation for approximately 90 ms. The amplifier will be enabled again and if the oscillation on the CTG pin returns, the GN fault will be detected and the SCR will be enabled. This total sequence cycle takes a maximum of 175 ms. During power up, an additional maximum of 175 ms is required. The maximum time required during power up is 350 ms. The sensitivity of the GN detection can be changed by capacitor C6 and resistor Rctg. The frequency of this CTG oscillation needs to be in the 2 kHz to 7 kHz.

The internal oscillator is trimmed to 2 MHz when the AC frequency is 60 Hz. If the AC frequency is lower, the GF trip threshold response time will be slower and the GN sensitivity will be lower.

The RES pin will bias at 1.2 volts and should have an external precision 120 k Ω resistor connected to the GND pin. This resistor sets up an internal precision current source.

The TE pin is used for internal production testing only. A 50 k Ω pull down resistor is connected to this pin. This pin should be open or connected to the GND pin (preferred).

The GNE pin has an internal 50 $k\Omega$ pull up resistor connected to the internal 3.3 V supply. If this pin is pulled low, the GN function will be disabled.

Contact ON Semiconductor for self-test requirement details and noise filtering recommendations.

ORDERING INFORMATION

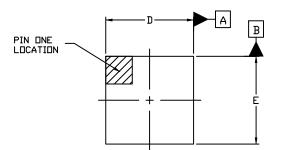
| Device | Package | Shipping † |
|---------------|--------------------|--------------------|
| NCS37015MNTWG | QFN16 (Pb-Free) | 3000 / Tape & Reel |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

QFN16 3x3, 0.5P

CASE 485FQ **ISSUE A**



TOP VIEW

SIDE VIEW

A3 (REF)

// 0.05 C

○ 0.05 C

NOTE 4

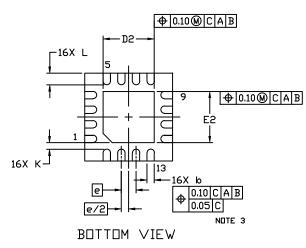
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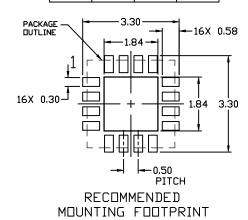
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS
- DIMENSION 6 APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.25 AND 0.30 MM FROM THE TERMINAL TIP.
- COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.



SEATING PLANE

| | MILLIMETERS | | | |
|-----|----------------|----------|------|--|
| DIM | MIN. | N□M. | MAX. | |
| Α | 0.80 | 0.90 | 1.00 | |
| A1 | | | 0.05 | |
| A3 | | 0.20 REF | | |
| b | 0.18 | 0.24 | 0.30 | |
| D | 2.95 | 3.00 | 3.05 | |
| D2 | 1.70 | 1.75 | 1.80 | |
| E | 2.95 | 3.00 | 3.05 | |
| E2 | 1.70 | 1.75 | 1.80 | |
| е | 0.50 BSC | | | |
| К | 0.18 TYP | | | |
| L | 0.30 0.40 0.50 | | | |





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